

Agilent E6832A W-CDMA Calibration Application

For the E6601A Wireless Communications Test Set

Data Sheet



The next generation of mobile phone manufacturing test.

E6601A is the newest test set from Agilent Technologies, designed especially for high-volume, test-mode manufacturing. Combining industry-leading measurement speed, selectable formats, flexible licensing, and an integrated open Windows® XP PC, the E6601A helps you achieve the lowest cost of test in mobile phone manufacturing.

The E6601A and its available technology-specific software applications deliver industry leading measurement speed and accuracy for your mobile phone test needs.

The Agilent E6832A W-CDMA Calibration Application is a non-signaling application optimized for W-CDMA and HSDPA mobile phone calibration. The E6832A also provides a choice of perpetual, transportable, or term licenses for maximizing asset utilization and your cost per test.

The test set and its applications use emerging advancements such as fast device tune features to deliver fast, high-quality calibration. Because it's Agilent, you can be confident—it operates using trusted, proven measurement methodology that ensures measurement integrity that is never compromised.

E6601A/E6890A Features and General Specifications

- · CW, AM, FM, DSB-SC source modulation
- · RF analyzer
- Spectrum monitor
- · Transmitter power measurements
- · Power versus time measurement
- · Frequency error measurement
- · Optional IQ capture waveform sampling
- · Internal OCXO timebase
- · Built-in open Windows XP PC
- · Built-in help system
- · Run test programs with internal or external PC
- GPIB, USB, and LAN connectivity and control

E6832A Features

Source modulation

· CW, amplitude, frequency, W-CDMA

Power measurements

- · Mean power
- · Root-raised cosine power

Spectral measurements

- · Spectrum emission mask
- Adjacent channel leakage
- · Spectrum monitor

Modulation quality

- · CW frequency error
- DPCH EVM, OBW, frequency error



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Technical Specifications

These specifications apply to an E6601A mainframe and the E6832A W-CDMA Calibration Application firmware revision A.04 or higher. Only feature additions beyond the E6890A General Purpose Application are included in this document. Specifications describe the test set's warranted performance and are valid for the unit's operation within $\pm 10~^{\circ}\text{C}$ of the last self alignment. All specifications are valid after a 30-minute warm-up period of continuous operation with valid self alignment. If the instrument has been off for longer than 48 hours, a 48-hour warm-up period followed by self alignment is required.

Supplemental characteristics are intended to provide typical, but non-warranted, performance parameters that may be useful in applying the instrument. These characteristics are shown in italics and labeled as "typical." All units shipped from the factory meet these typical numbers at +25 °C ambient temperature without including measurement uncertainty.

RF Generator

Frequency

W-CDMA cellular bands

Band I IMT-2000 2112 to 2168 MHz Band II U.S. PCS 1932 to 1988 MHz Band III DCS/PCS 1807 to 1878 MHz Band IV 2112 to 2153 MHz Band V U.S. Cellular 871 to 892 MHz 877 to 883 MHz Band VI UMTS800 Band VII UMTS2600 2620 to 2690 MHz 927 to 958 MHz Band VIII UMTS900 1844 to 1880 MHz Band IX UMTS1700 Band X UMTS Extended 2110 to 2170 MHz Band XI UMTS1500 1475.9 to 1500.9 MHz

Output level

Signal level is measured using a root-raised cosine (RRC) filter with a roll-off a=0.22 and a 3.84 MHz bandwidth.

Output level renges

Composite signal absolute level accuracy

(< ±10 °C and < 24 hours from last self alignment,

-108 to -15 dBm / 3.84 MHz)

RF IN/OUT port $< \pm 1.0 \text{ dB}$, $typically < \pm 0.65 \text{ dBm}$ RF OUT ONLY port $< \pm 1.0 \text{ dB}$, $typically < \pm 0.65 \text{ dBm}$

QPSK modulation

Residual EVM Typically < 3%

RF Analyzer

Frequency

W-CDMA cellular bands

Band I IMT-2000 1922 to 1978 MHz Band II U.S. PCS 1852 to 1908 MHz Band III DCS/PCS 1712 to 1783 MHz Band IV 1712 to 1753 MHz Band V U.S. Cellular 826 to 847 MHz Band VI UMTS800 832 to 838 MHz Band VII UMTS2600 2500 to 2570 MHz Band VIII UMTS900 882 to 913 MHz Band X UMTS Extended 1710 to 1770 MHz Band XI UMTS1500 1427.9 to 1452.9 MHz Band IX UMTS1700 1749 to 1785 MHz

Input level ranges

Average power -65 to +28 dBm/3.84 MHz Peak power -65 to +37 dBm/3.84 MHz (5 W)

Self alignment validity $\leq \pm 10$ °C change and ≤ 30 days from last self alignment

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DPCH Measurement Suite

Includes mean and RRC-filtered mean power, spectrum emission mask, ACLR, composite EVM frequency error, PCDE, and occupied bandwidth measurements.

Trigger setup

Delay -20 to +20 ms

Sources External, fall, immediate, rise

Mean and RRC-filtered mean power measurements

Input level range

Average power -61 to +28 dBm/3.84 MHz

Measurement accuracy¹

-54 to +28 dBm/3.84 MHz $< \pm 0.6$ dB, $typically < \pm 0.3$ dB -61 to < -54 dBm/3.84 MHz $< \pm 0.7$ dB, $typically < \pm 0.4$ dB

With < 48 hours warm-up before self alignment initiated

-54 to +28 dBm/3.84 MHz $< \pm 0.7$ dB, typically $< \pm 0.3$ dB -61 to < -54 dBm/3.84 MHz $< \pm 0.8$ dB, typically $< \pm 0.4$ dB

Measurement repeatability Typically $< \pm 0.05 dB$

Filter

Mean power-compliant filter

RRC-filtered mean power 3.84 MHz

Spectrum emission mask (SEM) measurement

This measurement provides a ratio of the transmitted power in a 3.84 MHz RRC bandwidth to offset frequencies, which are between 2.5 MHz and 12.5 MHz away from the UE carrier frequency.

Input level range

Average power +5 to +28 dBm/3.84 MHz

Measurement accuracy

2.5 to 12.5 MHz $< \pm 1.5$ dB, typically $< \pm 0.5$ dB

Offset frequency measurement bandwidths

2.5 to 3.5 MHz offsets 30 kHz 3.5 to 12.5 MHz offsets 1 MHz

In-band measurement filter 3.84 MHz (RRC)

Adjacent channel leakage ratio (ACLR) measurement

This measurement provides a ratio of the filtered mean transmitted power to the filtered mean power in an adjacent channel. Both the transmitted and the adjacent channel powers are measured with a filter that has an RRC response with roll-off a=0.22 and a bandwidth equal to the chip rate.

Input level range

Average power +5 to +28 dBm/3.84 MHz

Measurement accuracy

 ± 5 MHz offsets at -33 dB $< \pm 0.8$ dB, typically $< \pm 0.4$ dB ± 10 MHz offsets at -43 dB $< \pm 0.8$ dB, typically $< \pm 0.4$ dB

Residual noise floor

 ± 5 MHz offsets Typically < -53 dBc ± 10 MHz offsets Typically < -63 dBc Filter 3.84 MHz (RRC)

Error vector magnitude (EVM) measurement

This measurement calculates composite EVM and several other results relating to UE modulation quality.

Input level range

Average power —25 to +28 dBm/3.84 MHz

UE ranges

EVM \leq 35% rms Frequency error $< \pm 1$ kHz Timing error $< \pm 50$ chips

EVM measurement accuracy (Includes residual EVM)

UE EVM 0% rms < 2.5% rms
UE EVM 17.5% rms < 0.7% rms
UE EVM 35% rms < 0.5% rms

Filter 3.84 MHz (RRC)

Measurement results EVM, magnitude error, phase

error, origin offset

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^{1.} Additional accuracy error when using RF OUT ONLY port is $< \pm 0.1$ dB.

Frequency error measurement

Input level range

Average power -25 to +28 dBm/3.84 MHz

UE ranges

EVM $\leq 35\%$ rmsFrequency error $< \pm 1$ kHzTiming error $< \pm 50$ chipsFilter3.84 MHz (RRC)

Measurement accuracy $< (\pm 5 \text{ Hz} + \text{timebase accuracy})$

Peak code domain error (PCDE) measurement

Input level range

Average power —25 to +28 dBm/3.84 MHz

UE ranges

 $\begin{array}{lll} \text{EVM} & \leq 35\% \text{ rms} \\ \text{Frequency error} & < \pm 1 \text{ KHz} \\ \text{Timing error} & < \pm 50 \text{ chips} \\ \end{array}$ $\begin{array}{lll} \text{Filter} & 3.84 \text{ MHz (RRC)} \\ \end{array}$

Measurement accuracy $< \pm 0.3 \text{ dB}$

Occupied bandwidth (OBW) measurement

This measurement calculates the bandwidth containing 99.0% of the total integrated power of the transmitted signal, centered on the channel frequency.

Input level range

Average power +5 to +28 dBm/3.84 MHz **Measurement accuracy** $<\pm60$ kHz at 99.0% total

integrated power

Dynamic Power Measurement

Input level range

Average power -61 to +28 dBm/3.84 MHz

Amplitude capture range

With 4 dB crest factor $< \pm 2$ dB of expected power

Measurement accuracy¹

+2 to -45 dB of expected power

-54 to +28 dBm/3.84 MHz $$ < ± 0.6 dB, typically < ± 0.3 dB $$ -61 to < -54 dBm/3.84 MHz $$ < ± 0.7 dB, typically < ± 0.4 dB

+2 to -45 dB of expected power with < 48 hours warm-up before self alignment initiated

-54 to +28 dBm/3.84 MHz $< \pm 0.7$ dB, typically $< \pm 0.3$ dB -61 to < -54 dBm/3.84 MHz $< \pm 0.8$ dB, typically $< \pm 0.4$ dB

Measurement repeatability

Returning to same level Typically $< \pm 0.05 \ dB$ and frequency, no

temperature change and insignificant time change

Trigger setup

Sources External, fall, rise

Filters 1 kHz

30 kHz 100 kHz 300 kHz 640 kHz 1.23 MHz 1.28 MHz 1.6 MHz 3.84 MHz 5.0 MHz

8PSK estimated carrier power

GSM Tx power

W-CDMA mean power

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^{1.} Additional accuracy error when using RF OUT ONLY port is $< \pm 0.1$ dB.

Fast Device Tune Measurement

Allows simultaneous calibration of a device's transmitter output power and receiver input level across level and frequency in a single sweep (per frequency band). The device must operate in a test mode, which forces it to transmit a predefined series of power steps at various uplink frequencies, and also forces it to simultaneously tune its receiver to perform measurements (such as RSSI) of the test set's signal at various downlink frequencies and power levels.

Input level range

Average Tx power -61 to +28 dBm/3.84 MHz

 Measurement interval
 1 timeslot (667 μs)

 Measurement filter
 W-CDMA mean power

Power measurement accuracy¹

0 to -45 dB of expected power and 20 to 55 °C

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-54 to +28 dBm/3.84 MHz \phantom{0} < \pm 0.75 dB, typically < \pm 0.4 dB \phantom{0} -61 to < -54 dBm/3.84 MHz \phantom{0} < \pm 0.85 dB, typically < \pm 0.5 dB
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0 to $-45~\mathrm{dB}$ of expected power and 20 to 55 °C with 48-hours warm-up before self alignment initiated

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-54 to +28 dBm/3.84 MHz < \pm 0.85 dB, typically < \pm 0.4 dB -61 to < -54 dBm/3.84 MHz < \pm 0.95 dB, typically < \pm 0.5 dB
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Output level ranges (Rx level at)

Composite signal absolute output level accuracy

(< ±10 °C and < 24 hours from last self alignment)

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-108 to -15 dBm/ < \pm 1.0 dB, typically < \pm 0.65 dBm 3.84 MHz at RF IN/OUT port
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-108 to -5 dBm/ < ± 1.0 dB, typically < ± 0.65 dBm 3.84 MHz at RF OUT ONLY port

Output level settling (Rx level within 0.1 dB)

Amplitude switch < 1 ms, $typically < 250 \ \mu s$ Frequency switch within band < 1 ms, $typically < 500 \ \mu s$

Step size range 5 to 20 ms

Trigger setup

Sources Immediate, rise



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^{1.} Additional accuracy error when using RF OUT ONLY port is $< \pm 0.1$ dB.

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